

UNITED STATES PATENT AND TRADEMARK OFFICE
CERTIFICATE OF CORRECTION

PATENT NO. : 6,894,517 B2
APPLICATION NO. : 10/065432
DATED : May 17, 2005
INVENTOR(S) : Ting-Kuo Kang et al.

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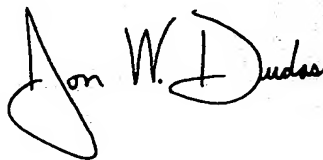
It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Please replace the title METHOD FOR MONITORING OXIDE QUALITY with the following new title:

METHOD OF MANUFACTURING A SEMICONDUCTOR DEVICE HAVING AN
OXIDE LAYER

Signed and Sealed this

Fifth Day of September, 2006

A handwritten signature in black ink, appearing to read "Jon W. Dudas". The signature is stylized with a large, looped initial "J" and a cursive "Dudas".

JON W. DUDAS
Director of the United States Patent and Trademark Office